

TASIS: Trend Analysis System for International Standards

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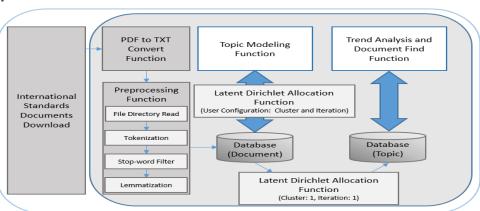




Introduction

- We apply text mining to standard documents to better understand trend analysis and research trends.
- We have collected ITU-T Recommendations and examined topics by performing topic modeling experiments based on a latent dirichlet allocation (LDA) algorithm.
- We have developed the Trend Analysis System for International Standards (TASIS), which performs topic modeling and trend analysis automatically, making it possible to analyze trends at various points, in accordance with user requirements.

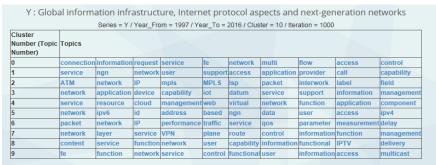
System Architecture





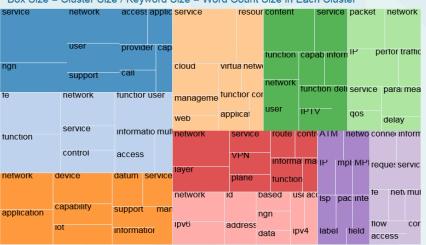


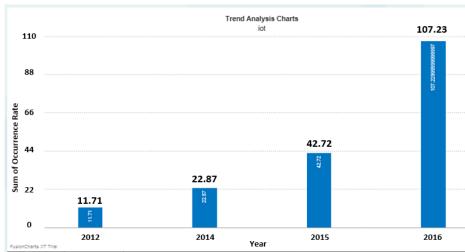
Topic Modeling Function / Trend Analysis Function



Tree Map

* Box Size = Cluster Size / Keyword Size = Word Count Size in Each Cluster





Document	Year	Occurrence Rate	Title
Y.2074	2015	23.89	Requirements for Internet of things devices and operation of Internet of things applications during disasters
Y.2066	2014	22.87	Common requirements of the Internet of things
Y.2068	2015	18.83	Functional framework and capabilities of the Internet of things
Y.4113	2016	17.09	Requirements of the network for the Internet of things
Y.2076	2016	16.84	Semantics based requirements and framework of the Internet of things
Y.4553	2016	15.83	Requirements of smartphone as sink node for IoT applications and services
Y.2078	2016	15.44	Application support models of the Internet of things
Y.2060	2012	11.71	Overview of the Internet of things
Y.4453	2016	11.17	Adaptive software framework for Internet of things devices
Y.2077	2016	9.54	Requirements of the plug and play capability of the Internet of things
Y.2340	2016	8.15	Next generation network evolution phase 1 – Overview
Y.4451	2016	7.21	Framework of constrained device networking in the IoT environments
Y.4702	2016	5.96	Common requirements and capabilities of device management in the Internet of things

